EFS-Web Receipt date: 06/26/2006

IAP20 Res'670...770 & 9 JUN 2006 PATENT

S/N Unknown

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: KITAOKA, et al. Examiner: Unknown

Serial No.: Unknown Group Art Unit: Unknown

Filed: Herewith Docket: 10873.1915USWO

Title: METHOD FOR PRODUCING GROUP III NITRIDE

> CRYSTAL, GROUP III NITRIDE CRYSTAL OBTAINED BY SUCH METHOD, AND GROUP III NITRIDE SUBSTRATE

USING THE SAME

CERTIFICATE UNDER 37 CFR 1.10

Express Mail mailing label number: EV 858801894 US Date of Deposit: June 26, 2006

I hereby certify that the papers listed below are being deposited with the United States Postal Service Express Mail Post Office to Addressee service under 37 CFR 1.10 in an envelope addressed to: Mail Stop PCT, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

Name: Abbie Larki

## INFORMATION DISCLOSURE STATEMENT (37 C.F.R. § 1.97(c))

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

With regard to the above-identified application, the items of information listed on the enclosed Form 1449 are brought to the attention of the Examiner.

This statement should be considered because it is submitted within three months of the filing date of the above-identified application, which is not an application under 37 C.F.R. §1.53(d). Accordingly, no fee is due for consideration of the items listed on the enclosed Form 1449.

In accordance with 37 C.F.R. §1.98(a)(2), a copy of each foreign document or other information listed on the enclosed Form 1449 is provided. As this application was filed after June 30, 2003, copies of the cited U.S. Patent Documents are not included.

## IAP20 Rec'SPELIFIO 26 JUN 2006

A concise explanation of the relevance of each non-English language document or other information is a follows (37 C.F.R. §(a)(3)):

An English abstract and/or a partial English translation has been included for each Japanese reference.

No representation is made that a reference is "prior art" within the meaning of 35 U.S.C. §§ 102 and 103 and Applicants reserve the right, pursuant to 37 C.F.R. § 1.131 or otherwise, to establish that the reference(s) are not "prior art." Moreover, Applicants do not represent that a reference has been thoroughly reviewed or that any relevance of any portion of a reference is intended.

Consideration of the items listed is respectfully requested. Pursuant to the provisions of M.P.E.P. 609, it is requested that the Examiner return a copy of the attached Form 1449, marked as being considered and initialed by the Examiner, to the undersigned with the next official communication.

Please charge any additional fees or credit any overpayment to Deposit Account No. 50-3478.

Respectfully submitted,

HAMRE, SCHUMANN, MUELLER & LARSON, P.C. P.O. Box 2902-0902

P.O. Box 2902-0902 Minneapolis, MN 55402-0902 (612) 455-3800

By:

Douglas P. Muelle

Dated: June 26, 2006

DPM/pjk

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## EFS-Web Receipt date: 06/26/2006

IAP20 Rec's FC.19584785 NRA2006792

Jate Mailed: June 26, 2006		Sheet I of I			
FORM 1449*	INFORMATION DISCLOSURE STATEMENT	Docket Number: 10873.1915USWO	Application Number:		
	IN AN APPLICATION	Applicant: KITAOKA, et al.			
	(Use several sheets if necessary)	Filing Date: Herewith	Group Art Unit: Unknown		

		U.S. I	PATENT DOCUMEN	rs			
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	6,592,663	July, 2003	Sarayama, et al.				
	2006/0051942	March, 2006	Sasaki, et al.				
		FOREIG	N PATENT DOCUM	ENTS			
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	56-160400	December, 1981	Japan			Abstract	
	95/04845	February, 1995	WIPO				
	11-135831	May, 1999	Japan			Partial & Abstract	
	2002-293696	October, 2002	Japan			Abstract	
	2003-257998	September, 2003	Japan			Abstract	
	ОТНЕ	R DOCUMENTS (In	cluding Author, Title, I	Date, Pertinent P	ages, Etc.)		
		a, et al., Synthesis of pp. L1440-1442	Bulk GaN Single Crysta	ils Using Na-Ca	Flux" Jpn. J. App	l. Phys. vol. 41	, Decemb

53148 PATENT TRADEMARK OFFICE

EXAMINER	/Matthew Song/	DATE CONSIDERED 04/09/2008	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to the Applicant.